TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

## 2 S A 1 2 4 4

## HIGH CURRENT SWITCHING APPLICATIONS

Low Collector Saturation Voltage

:  $V_{CE(sat)} = -0.4 \text{ V (Max.)}$  at  $I_{C} = -3 \text{ A}$ 

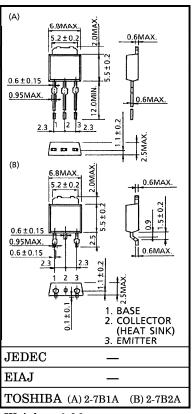
High Speed Switching Time :  $t_{stg} = 1.0 \,\mu s$  (Typ.)

Complementary to 2SC3074

## MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Collector-Base Voltage	$v_{\mathrm{CBO}}$	-60	V	
Collector-Emitter Voltage	V <sub>CEO</sub>	-50	V	
Emitter-Base Voltage	$v_{\mathrm{EBO}}$	-5	V	
Collector Current	IC	-5	A	
Base Current	$I_{\mathrm{B}}$	-1	A	
Collector Power $Ta = 25^{\circ}$	C Ba	1.0	w	
Dissipation $Tc = 25^{\circ}$	P <sub>C</sub>	20	] <b>''</b> [	
Junction Temperature	Tj	150	$^{\circ}\mathrm{C}$	
Storage Temperature Range	$T_{ m stg}$	-55~150	°C	

Unit in mm



Weight: 0.36 g

The information contained herein is subject to change without notice.

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARA	CTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut	-off Current	$I_{CBO}$	$V_{CB} = -50 \text{ V}, I_{E} = 0$		_	-1	$\mu$ A
Emitter Cut-	off Current	$I_{EBO}$	$V_{EB} = -5 \text{ V}, I_{C} = 0$	_	_	-1	$\mu$ A
Collector-Emi Breakdown V		V <sub>(BR)</sub> CEO	$I_{C} = -10 \text{ mA}, I_{B} = 0$	-50	_	_	V
DC Current Gain		hFE (1) (Note)	$V_{CE} = -1 V, I_{C} = -1 A$	70	_	240	
		hFE (2)	$V_{CE} = -1 V, I_{C} = -3 A$	30	_	_	
Saturation (	Collector-Emitter	V <sub>CE</sub> (sat)	$I_{\rm C} = -3  {\rm A}, \ I_{\rm B} = -0.15  {\rm A}$	_	-0.2	-0.4	$\mathbf{v}$
Voltage I	Base-Emitter	V <sub>BE (sat)</sub>	$I_C = -3 \text{ A}, I_B = -0.15 \text{ A}$		-0.9	-1.2	v
Transition Frequency		$ m f_{T}$	$V_{CE} = -4 V, I_{C} = -1 A$	_	60	—	MHz
Collector Output Capacitance		$C_{ob}$	$V_{CB} = -10 \text{ V}, I_{E} = 0,$ f = 1  MHz	ı	170	_	рF
Switching Time	Turn-on Time	t <sub>on</sub>	INPUT IB2 OUTPUT  IB1 IB1 IB2 IB1	1	0.1	_	
	Storage Time	t <sub>stg</sub>			1.0	_	μs
	Fall Time	$t_f$	$ \begin{array}{c} -I_{B1} = I_{B2} = 0.15 \text{ A} \\ \text{DUTY CYCLE} \leq 1\% \end{array}  V_{CC} = -30 \text{ V} $	1	0.1	_	

Note : hFE (1) Classification  $O:70\sim140~Y:120\sim240$ 

